

Application/Control No.	Applicant(s)/Patent under Reexamination
10/686,067	NAKATSUJI ET AL.
Examiner	Art Unit
Duc M. Nguyen	2618

	SEAR	CHED	
Class	Subclass	Date	Examiner
455	300	4/17/2006	DN
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	575.1		
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361	760 761		
	782 783		
	800 816	D D	+
174	32	٥	У
	35R	4/17/2006	DN

INT	INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner				
claim	search	4/12/2006	DN				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
		DATE	EXMR	
EAST		4/12/2006	DN	
EAST		4/17/2006	DN	